Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/553,698	PFANNSCHMIDT ET AL.
Examiner	Art Unit
Tran N. Nguyen	2834

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Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
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